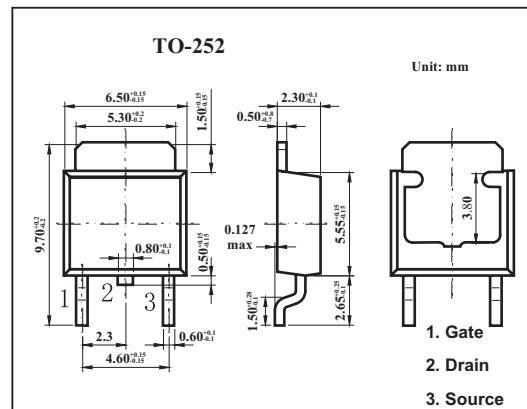
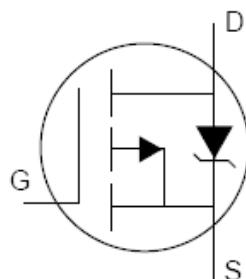


HEXFET® Power MOSFET

KRFR9310

■ Features

- Surface Mount
- Fast Switching
- P-Channel
- Advanced Process Technology
- Fully Avalanche Rated



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	Rating	Unit
Continuous Drain Current, Vgs @ -10V, Tc = 25°C	Id	-1.8	A
Continuous Drain Current, Vgs @ -10V, Tc = 100°C	Id	-1.1	
Pulsed Drain Current*1	Idm	-7.2	
Power Dissipation Tc = 25°C	Pd	50	W
Linear Derating Factor		0.4	W/°C
Gate-to-Source Voltage	Vgs	±20	V
Single Pulse Avalanche Energy*3	Eas	92	mJ
Avalanche Current *1	Iar	-1.8	A
Repetitive Avalanche Energy *1	Ear	5	mJ
Peak Diode Recovery dv/dt *2	Dv/dt	-24	V/ns
Operating Junction and Storage Temperature Range	Tj, Tstg	-55 to + 150	°C
Junction-to-Case	RθJC	2.5	°C/W
Junction-to-Ambient	RθJA	50	°C/W
Junction-to-Ambient	RθJA	110	°C/W

*1 Repetitive rating; pulse width limited by max. junction temperature.

*2 Isd ≤ -1.1A, di/dt ≤ 450A/μ s, Vdd ≤ V(BR)DSS, TJ ≤ 150°C

*3 Starting TJ = 25°C, L = 57 mH, RG = 25 Ω, IAS = -1.8A.

KRFR9310

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250 μA	-400			V
Breakdown Voltage Temp. Coefficient	△V _{(BR)DSS} /△T _J	I _D = -1mA, Reference to 25°C		-0.41		VI/°C
Static Drain-to-Source On-Resistance	R _{Ds(on)}	V _{GS} = -10V, I _D = -1.1A*1			7.0	Ω
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250 μA	-2.0		-4.0	V
Forward Transconductance	g _f	V _{DS} = -50V, I _D = -1.1A*1	0.91			S
Drain-to-Source Leakage Current	I _{DSS}	V _{DS} = -400V, V _{GS} = 0V		-100		μA
		V _{DS} = -320V, V _{GS} = 0V, T _J = 125°C		-500		
Gate-to-Source Forward Leakage	I _{GSS}	V _{GS} = 20V		-100		nA
Gate-to-Source Reverse Leakage		V _{GS} = -20V			100	
Total Gate Charge	Q _g	I _D = -1.1A			13	nC
Gate-to-Source Charge	Q _{gs}	V _{DS} = -320V			3.2	
Gate-to-Drain ("Miller") Charge	Q _{gd}	V _{GS} = -10V,*1			5.0	
Turn-On Delay Time	t _{d(on)}	V _{DD} = -200V		11		ns
Rise Time	t _r	I _D = -1.1A		10		
Turn-Off Delay Time	t _{d(off)}	R _G = 21 Ω		25		
Fall Time	t _f	R _D = 180 Ω *1		24		
Internal Drain Inductance	L _D	Between lead, 6mm (0.25in.) from package and center of die contact		4.5		nH
Internal Source Inductance	L _S			7.5		nH
Input Capacitance	C _{iss}	V _{GS} = 0V		270		pF
Output Capacitance	C _{oss}	V _{DS} = -25V		50		
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz		8.0		
Continuous Source Current (Body Diode)	I _s	MOSFET symbol showing the integral reverse p-n junction diode.			-1.8	A
Pulsed Source Current (Body Diode) *2	I _{sM}				-7.2	
Diode Forward Voltage	V _{SD}	T _J = 25°C, I _s = -1.1A, V _{GS} = 0V*1			-4.0	V
Reverse Recovery Time	t _{rr}	T _J = 25°C, I _F = -1.1A		170	260	ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100A/ μ s*1		640	960	μ C
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _s +L _D)				

*1 Pulse width ≤ 300 μs; duty cycle ≤ 2%.

*2 Repetitive rating; pulse width limited by max

